N-channel TrenchPLUS standard level FET

Rev. 02 — 10 February 2009

**Product data sheet** 

### 1. Product profile

### 1.1 General description

Standard level N-channel enhancement mode Field-Effect Transistor (FET) in a plastic package using TrenchMOS technology. The devices include TrenchPLUS diodes for ElectroStatic Discharge (ESD) protection and temperature sensing. This product has been designed and qualified to the appropriate AEC standard for use in automotive critical applications.

### **1.2 Features and benefits**

- Allows responsive temperature monitoring due to integrated temperature sensor
- Electrostatically robust due to integrated protection diodes

### 1.3 Applications

 Electrical Power Assisted Steering (EPAS)

- Low conduction losses due to low on-state resistance
- Q101 compliant
- Suitable for standard level gate drive sources
- Variable Valve Timing for engines

### 1.4 Quick reference data

#### Table 1. Quick reference

| Symbol              | Parameter   | Conditions   | Min  | Тур   | Max   | Unit |
|---------------------|---|--|------|-------|-------|------|
| V <sub>DS</sub>     | drain-source voltage                                  | T <sub>j</sub> ≥ 25 °C; T <sub>j</sub> ≤ 175 °C  | -    | -     | 75    | V    |
| Static ch           | aracteristics   |  |      |       |       |      |
| R <sub>DSon</sub>   | drain-source<br>on-state resistance                   | $V_{GS} = 10 \text{ V}; I_D = 50 \text{ A};$<br>$T_j = 25 \text{ °C}; \text{ see } Figure 7;$<br>see  Figure 8 | -    | 8     | 9     | mΩ   |
| $S_{F(TSD)}$        | temperature sense<br>diode temperature<br>coefficient | I <sub>F</sub> = 250 μA; T <sub>j</sub> ≥ -55 °C;<br>T <sub>j</sub> ≤ 175 °C                                   | -1.4 | -1.54 | -1.68 | mV/K |
| V <sub>F(TSD)</sub> | temperature sense<br>diode forward<br>voltage         | I <sub>F</sub> = 250 μA; T <sub>j</sub> = 25 °C  | 648  | 658   | 668   | mV   |



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### 2. Pinning information

| Table 2. | Pinning | information                 |                    |                |
|----------|---------|-----------------------------|--------------------|----------------|
| Pin      | Symbol  | Description                 | Simplified outline | Graphic symbol |
| 1        | G       | gate                        |                    |                |
| 2        | А       | anode                       | mb                 |                |
| 3        | D       | drain                       |                    |                |
| 4        | К       | cathode                     | i i<br>!           | (☆ └ 平)        |
| 5        | S       | source                      |                    |                |
| mb       | D       | mounting base; connected to |                    | S K            |
|          |         | drain                       | SOT426<br>(D2PAK)  | mbl317         |

### 3. Ordering information

# Table 3. Ordering information Type number Package Name Description Version BUK7109-75ATE D2PAK plastic single-ended surface-mounted package (D2PAK); 5 leads (one lead cropped) SOT426

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### 4. Limiting values

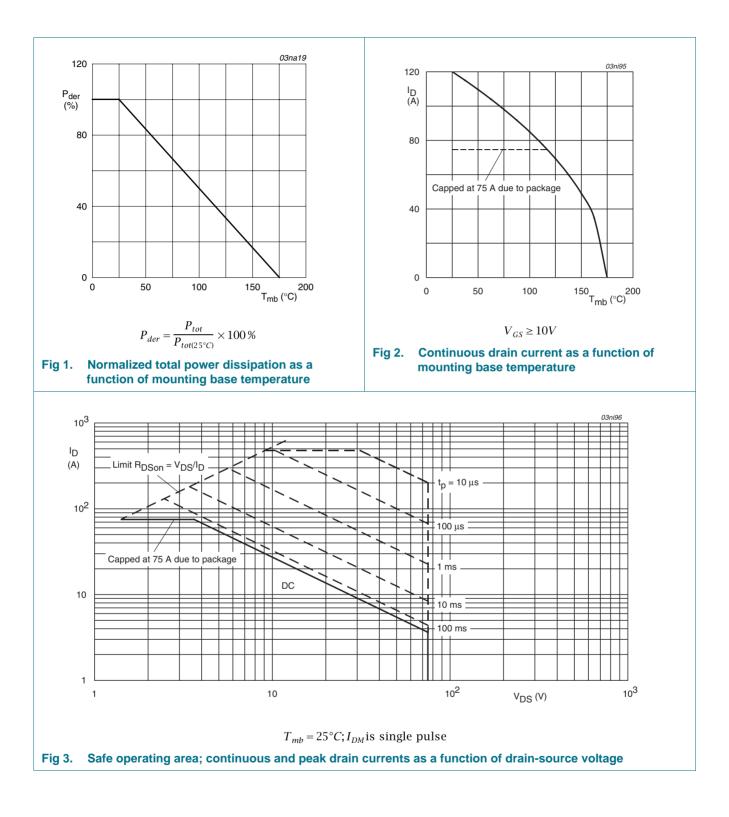
#### Table 4.Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

| Symbol               | Parameter  | Conditions   |     | Min  | Max | Unit |
|----------------------|--|--|-----|------|-----|------|
| V <sub>DS</sub>      | drain-source voltage                               | T <sub>j</sub> ≥ 25 °C; T <sub>j</sub> ≤ 175 °C  |     | -    | 75  | V    |
| V <sub>DGS</sub>     | drain-gate voltage                                 |  |     | -    | 75  | V    |
| V <sub>GS</sub>      | gate-source voltage                                |  |     | -20  | 20  | V    |
| I <sub>D</sub>       | drain current                                      | $T_{mb} = 25 \text{ °C}; V_{GS} = 10 \text{ V}; \text{ see } \frac{\text{Figure 2}}{\text{Figure 3}};$   | [1] | -    | 120 | А    |
|                      |  |  | [2] | -    | 75  | А    |
|                      |  | T <sub>mb</sub> = 100 °C; V <sub>GS</sub> = 10 V; see <u>Figure 2</u>  | [2] | -    | 75  | А    |
| I <sub>DM</sub>      | peak drain current                                 | $T_{mb}$ = 25 °C; $t_p \le 10 \ \mu$ s; pulsed; see <u>Figure 3</u>  |     | -    | 480 | А    |
| P <sub>tot</sub>     | total power dissipation                            | T <sub>mb</sub> = 25 °C; see <u>Figure 1</u>   |     | -    | 272 | W    |
| I <sub>GS(CL)</sub>  | gate-source clamping                               | continuous   |     | -    | 10  | mA   |
|                      | current  | pulsed; $t_p = 5 \text{ ms}; \delta = 0.01$  |     | -    | 50  | mA   |
| Visol(FET-TSD)       | FET to temperature sense diode isolation voltage   |  |     | -100 | 100 | V    |
| T <sub>stg</sub>     | storage temperature                                |  |     | -55  | 175 | °C   |
| Tj                   | junction temperature                               |  |     | -55  | 175 | °C   |
| Source-drai          | n diode  |  |     |      |     |      |
| I <sub>S</sub>       | source current                                     | T <sub>mb</sub> = 25 °C  | [1] | -    | 120 | А    |
|                      |  |  | [2] | -    | 75  | А    |
| I <sub>SM</sub>      | peak source current                                | $t_p \le 10 \ \mu s$ ; pulsed; $T_{mb} = 25 \ ^{\circ}C$   |     | -    | 480 | А    |
| Avalanche r          | uggedness  |  |     |      |     |      |
| E <sub>DS(AL)S</sub> | non-repetitive<br>drain-source avalanche<br>energy | $    I_D = 75 \text{ A};  \text{V}_{sup} \leq 75 \text{ V};  \text{R}_{GS} = 50  \Omega;  \text{V}_{GS} = 10 \text{ V}; \\  \text{T}_{j(\text{init})} = 25 ^{\circ}\text{C}; \text{ unclamped} $ |     | -    | 739 | mJ   |
| Electrostatio        | c discharge  |  |     |      |     |      |
| V <sub>esd</sub>     | electrostatic discharge voltage                    | HBM; C = 100 pF; R = 1.5 k $\Omega$  |     | -    | 6   | kV   |

[1] Current is limited by power dissipation chip rating.

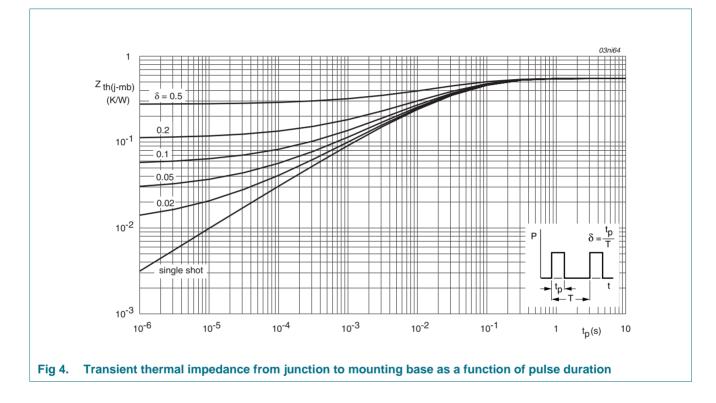
[2] Continuous current is limited by package.



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### 5. Thermal characteristics

| Table 5.              | Thermal characteristics                                 |  |     |     |      |      |
|-----------------------|---|--|-----|-----|------|------|
| Symbol                | Parameter   | Conditions   | Min | Тур | Max  | Unit |
| R <sub>th(j-a)</sub>  | thermal resistance from junction to ambient             | minimum footprint; mounted on a<br>printed-circuit board | -   | 50  | -    | K/W  |
| R <sub>th(j-mb)</sub> | thermal resistance from<br>junction to mounting<br>base | see Figure 4   | -   | -   | 0.55 | K/W  |

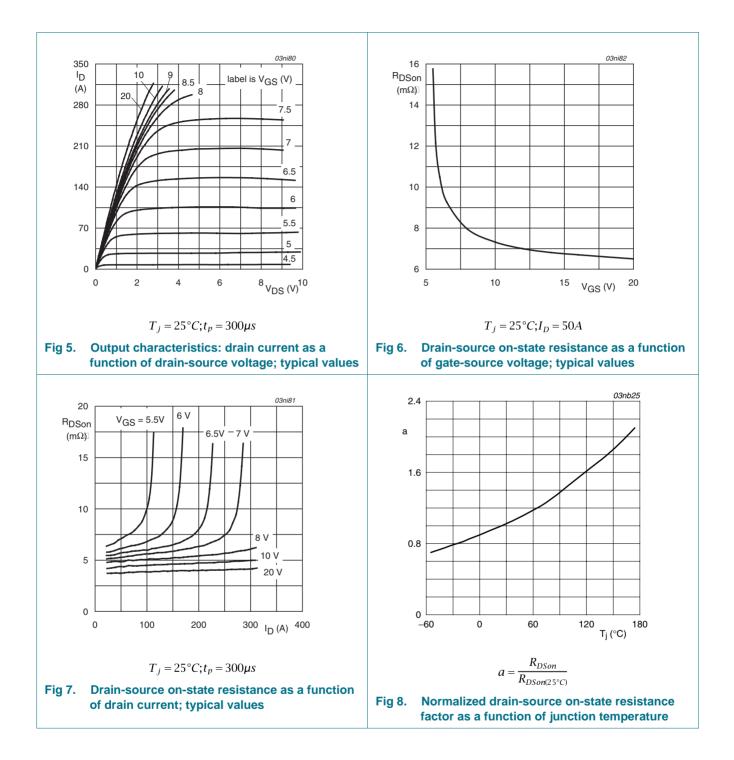


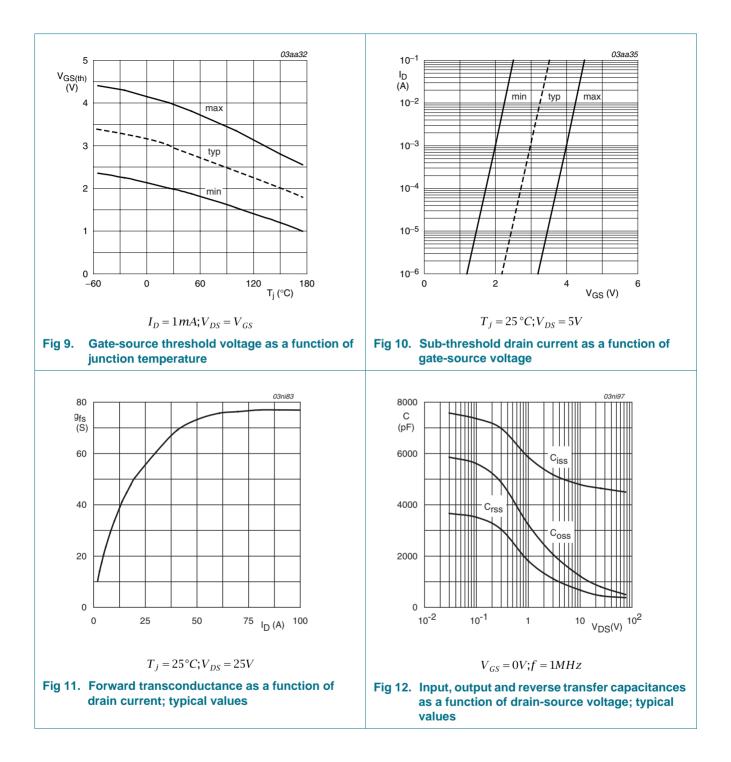
#### N-channel TrenchPLUS standard level FET

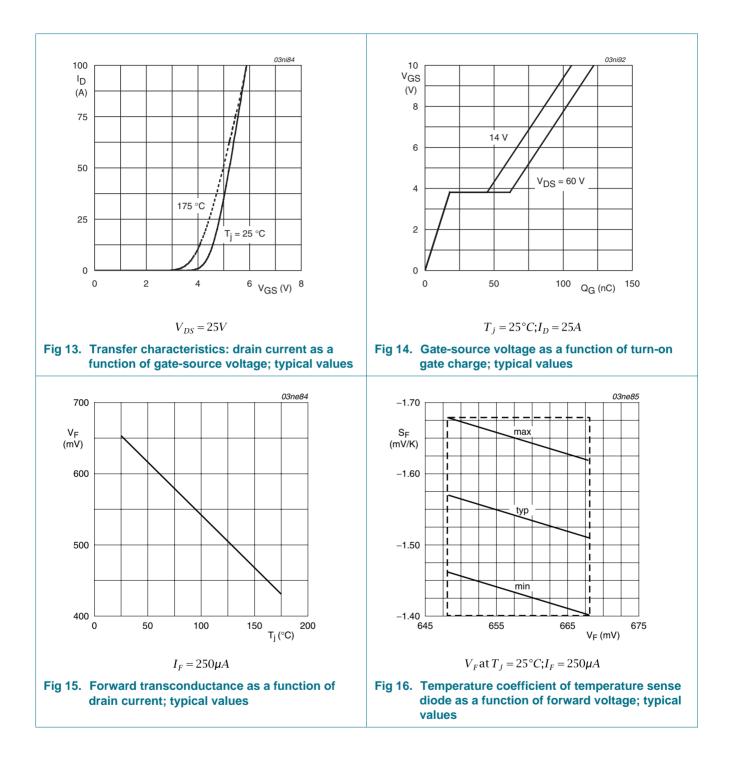
### 6. Characteristics

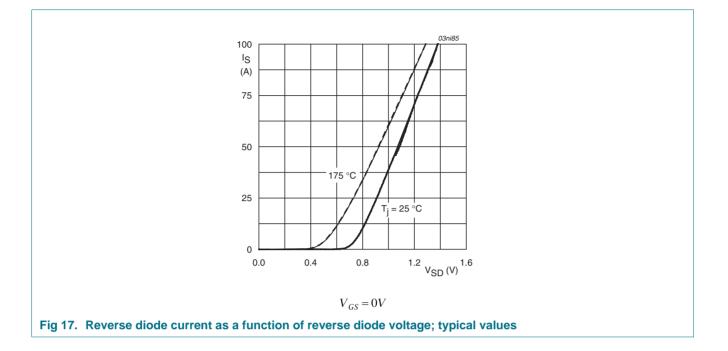
| Table 6.               | Characteristics  |  |      |       |       |      |
|------------------------|--|--|------|-------|-------|------|
| Symbol                 | Parameter  | Conditions   | Min  | Тур   | Max   | Unit |
| Static cha             | racteristics   |  |      |       |       |      |
| V <sub>(BR)DSS</sub>   | drain-source   | $I_D = 0.25 \text{ mA}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ °C}$                                 | 75   | -     | -     | V    |
|                        | breakdown voltage  | $I_D$ = 0.25 mA; $V_{GS}$ = 0 V; $T_j$ = -55 °C  | 70   | -     | -     | V    |
| V <sub>GS(th)</sub>    | gate-source threshold voltage                            | $I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = 25 \text{ °C};$<br>see Figure 9                        | 2    | 3     | 4     | V    |
|                        |  | $I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = 175 \text{ °C};$<br>see Figure 9                       | 1    | -     | -     | V    |
|                        |  | $I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = -55 \text{ °C};$<br>see <u>Figure 9</u>                | -    | -     | 4.4   | V    |
| I <sub>DSS</sub>       | drain leakage current                                    | $V_{DS} = 75 \text{ V};  V_{GS} = 0 \text{ V};  T_j = 25 ^{\circ}\text{C}$                         | -    | 0.1   | 10    | μΑ   |
|                        |  | $V_{DS} = 75 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 175 \text{ °C}$                                | -    | -     | 250   | μΑ   |
| V <sub>(BR)GSS</sub>   | gate-source breakdown<br>voltage                         | I <sub>G</sub> = 1 mA; V <sub>DS</sub> = 0 V; T <sub>j</sub> ≥ -55 °C;<br>T <sub>j</sub> ≤ 175 °C  | 20   | 22    | -     | V    |
|                        |  | I <sub>G</sub> = -1 mA; V <sub>DS</sub> = 0 V; T <sub>j</sub> ≥ -55 °C;<br>T <sub>j</sub> ≤ 175 °C | 20   | 22    | -     | V    |
| I <sub>GSS</sub>       | gate leakage current                                     | $V_{DS} = 0 \text{ V}; V_{GS} = 10 \text{ V}; T_j = 25 \text{ °C}$                                 | -    | 22    | 1000  | nA   |
|                        |  | $V_{DS} = 0 \text{ V}; \text{ V}_{GS} = -10 \text{ V}; \text{ T}_{j} = 25 \text{ °C}$              | -    | 22    | 1000  | nA   |
|                        |  | $V_{DS} = 0 \text{ V}; \text{ V}_{GS} = 10 \text{ V}; \text{ T}_{j} = 175 \text{ °C}$              | -    | -     | 10    | μΑ   |
|                        |  | $V_{DS} = 0 V; V_{GS} = -10 V; T_j = 175 °C$   | -    | -     | 10    | μΑ   |
| R <sub>DSon</sub>      | drain-source on-state<br>resistance                      | $V_{GS}$ = 10 V; $I_D$ = 50 A; $T_j$ = 25 °C;<br>see <u>Figure 7</u> ; see <u>Figure 8</u>         | -    | 8     | 9     | mΩ   |
|                        |  | $V_{GS}$ = 10 V; $I_D$ = 50 A; $T_j$ = 175 °C;<br>see <u>Figure 7</u> ; see <u>Figure 8</u>        | -    | -     | 19    | mΩ   |
| V <sub>F(TSD)</sub>    | temperature sense<br>diode forward voltage               | I <sub>F</sub> = 250 μA; T <sub>j</sub> = 25 °C  | 648  | 658   | 668   | mV   |
| S <sub>F(TSD)</sub>    | temperature sense<br>diode temperature<br>coefficient    | I <sub>F</sub> = 250 μA; T <sub>j</sub> ≥ -55 °C; T <sub>j</sub> ≤ 175 °C                          | -1.4 | -1.54 | -1.68 | mV/K |
| V <sub>F(TSD)hys</sub> | temperature sense<br>diode forward voltage<br>hysteresis | $I_F > 125 \ \mu\text{A}; I_F < 250 \ \mu\text{A}; T_j = 25 \ ^\circ\text{C}$                      | 25   | 32    | 50    | mV   |
| Dynamic o              | characteristics  |  |      |       |       |      |
| Q <sub>G(tot)</sub>    | total gate charge  | $I_D = 25 \text{ A}; V_{DS} = 60 \text{ V}; V_{GS} = 10 \text{ V};$                                | -    | 121   | -     | nC   |
| Q <sub>GS</sub>        | gate-source charge                                       | T <sub>j</sub> = 25 °C; see <u>Figure 14</u>   | -    | 20    | -     | nC   |
| Q <sub>GD</sub>        | gate-drain charge  |  | -    | 44    | -     | nC   |
| C <sub>iss</sub>       | input capacitance  | $V_{GS} = 0 V; V_{DS} = 25 V; f = 1 MHz;$  | -    | 4700  | -     | pF   |
| C <sub>oss</sub>       | output capacitance                                       | T <sub>j</sub> = 25 °C; see <u>Figure 12</u>   | -    | 800   | -     | pF   |
| C <sub>rss</sub>       | reverse transfer<br>capacitance                          |  | -    | 455   | -     | pF   |

| Table 6.            | Characteristics continued     |  |     |      |     |      |  |  |
|---------------------|-------------------------------|--|-----|------|-----|------|--|--|
| Symbol              | Parameter                     | Conditions   | Min | Тур  | Max | Unit |  |  |
| t <sub>d(on)</sub>  | turn-on delay time            |  | -   | 35   | -   | ns   |  |  |
| t <sub>r</sub>      | rise time                     |  | -   | 108  | -   | ns   |  |  |
| t <sub>d(off)</sub> | turn-off delay time           |  | -   | 185  | -   | ns   |  |  |
| t <sub>f</sub>      | fall time                     |  | -   | 100  | -   | ns   |  |  |
| L <sub>D</sub>      | internal drain<br>inductance  | measured from upper edge of drain<br>mounting base to centre of die; T <sub>j</sub> = 25 °C                    | -   | 2.5  | -   | nH   |  |  |
| L <sub>S</sub>      | internal source<br>inductance | measured from source lead to source bond pad; $T_j = 25 \text{ °C}$  | -   | 7.5  | -   | nH   |  |  |
| Source-d            | rain diode                    |  |     |      |     |      |  |  |
| V <sub>SD</sub>     | source-drain voltage          | I <sub>S</sub> = 25 A; V <sub>GS</sub> = 0 V; T <sub>j</sub> = 25 °C;<br>see <u>Figure 17</u>                  | -   | 0.85 | 1.2 | V    |  |  |
| t <sub>rr</sub>     | reverse recovery time         | $I_{S} = 20 \text{ A}; \text{ d}I_{S}/\text{d}t = -100 \text{ A}/\mu\text{s}; \text{ V}_{GS} = -10 \text{ V};$ | -   | 75   | -   | ns   |  |  |
| Q <sub>r</sub>      | recovered charge              | V <sub>DS</sub> = 30 V; T <sub>j</sub> = 25 °C   | -   | 270  | -   | nC   |  |  |









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### 7. Package outline

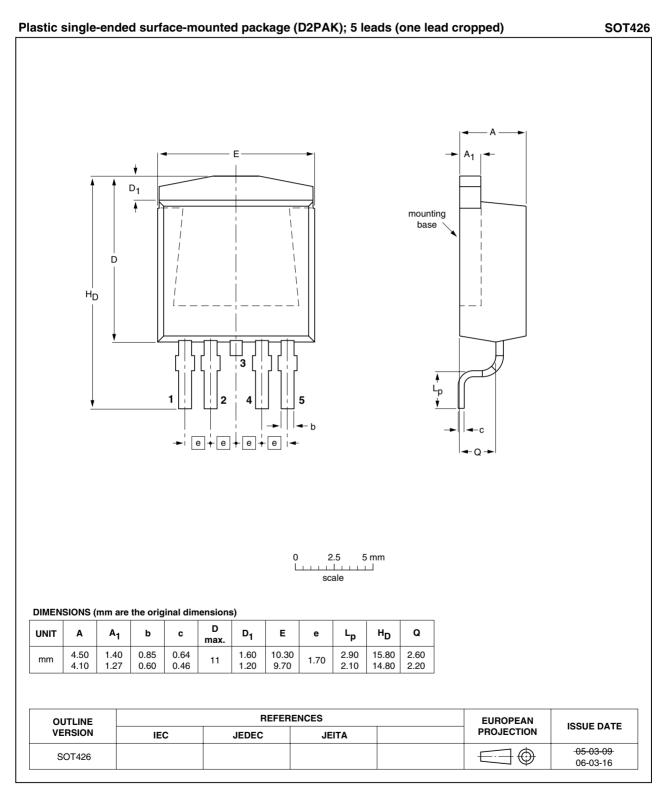


Fig 18. Package outline SOT426 (D2PAK)

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# 8. Revision history

| Table 7. Revision histo                 | ory                             |  |                          |                      |
|---|---------------------------------|--|--------------------------|----------------------|
| Document ID                             | Release date                    | Data sheet status                                    | Change notice            | Supersedes           |
| BUK7109-75ATE_2                         | 20090210                        | Product data sheet                                   | -                        | BUK71_7909_75ATE-01  |
| Modifications:                          |                                 | of this data sheet has bee<br>of NXP Semiconductors. | n redesigned to comply w | ith the new identity |
|   | <ul> <li>Legal texts</li> </ul> | have been adapted to the                             | new company name whe     | re appropriate.      |
|   | <ul> <li>Type numb</li> </ul>   | er BUK7109-75ATE separ                               | ated from data sheet BUk | (71_7909_75ATE-01.   |
| BUK71_7909_75ATE-01<br>(9397 750 09878) | 20020812                        | Product data sheet                                   | -                        | -                    |

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| Document status [1][2]         | Product status <sup>[3]</sup> | Definition  |
|--------------------------------|-------------------------------|---|
| Objective [short] data sheet   | Development                   | This document contains data from the objective specification for product development. |
| Preliminary [short] data sheet | Qualification                 | This document contains data from the preliminary specification.                       |
| Product [short] data sheet     | Production                    | This document contains the product specification.                                     |

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions"

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